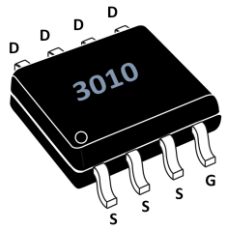
KL Silicon N-Channel Power MOSFET

V_{DSS}	30	V
I_D	10	A
P_D	2.5	W
$R_{DS(ON)type}$	7	mΩ

SOP-8



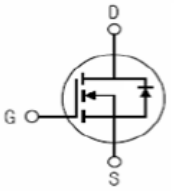
General Description:

The KL3010-8 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is SOP-8, which accords with the RoHS standard.

Features:

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

Inner Equivalent Principium Chart



Applications:

- PWM applications
- Load switch
- Power management

Absolute (Tc=25℃ unless otherwise specified):

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	30	V
I_D	Continuous Drain Current	10	A
	Continuous Drain Current T_C = 70 °C	8	A
I_{DM}[a1]	Pulsed Drain Current	50	A
V_{GS}	Gate-to-Source Voltage	±20	V
dv/dt[a3]	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	2.5	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, −55 to 150	℃
T_L	Maximum Temperature for Soldering	300	℃

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Electrical Characteristics (Tc= 25℃ unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	V_{GS}=0V, I_D=-250μA	30	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	I_D=-250uA,Reference25℃	--	0.1	--	V/℃
I_{DSS}	Drain to Source Leakage Current	V_{DS}=30,V_{GS}=0V,T_a=25℃	--	--	1	μA
		V_{DS}=24V,V_{GS}=0V,T_a=125℃	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	V_{GS}=+20V	--	--	1	μA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	V_{GS}=-20V	--	--	-1	μA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	V_{GS}=10V,I_D=5A	--	7	10	mΩ
$R_{DS(ON)}$	Drain-to-Source On-Resistance	V_{GS}=4.5V,I_D=5.0A	--	11	15	mΩ
$V_{GS(TH)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=250μA	1.0	1.3	2.5	V
Pulse width tp≤380μs,δ≤2%						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
g_{fs}	Forward Transconductance	V_{DS}=5V,I_D=10A	15	--	--	S
C_{iss}	Input Capacitance	V_{GS}=0V,V_{DS}=15V f=1.0MHz	--	1600	--	pF
C_{oss}	Output Capacitance		--	300	--	
C_{rss}	Reverse Transfer Capacitance		--	180	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	I_D=1A,V_{DD}=25V V_{GS}=10V,R_G=6Ω	--	30	--	ns
t_r	Rise Time		--	20	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	100	--	
t_f	Fall Time		--	80	--	
Q_g	Total Gate Charge	I_D=5A,V_{DD}=30V V_{GS}=5V	--	10	--	nC
Q_{gs}	Gate to Source Charge		--	5	--	
Q_{gd}	Gate to Drain (“Miller”)Charge		--	3	--	

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Source-Drain Diode Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I_S	Continuous Source Current (Body Diode)		--	--	10	A
I_{SM}	Maximum Pulsed Current (Body Diode)		--	--	50	A
V_{SD}	Diode Forward Voltage	I_S=10A,V_{GS}=0V	--	--	1.5	V
t_{rr}	Reverse Recovery Time	I_S=10A,T_j = 25°C	--	100	--	ns
Q_{rr}	Reverse Recovery Charge	dI_F/dt=100A/us, V_{GS}=0V	--	240	--	nC
Pulse width tp≤380μs,δ≤2%						

Symbol	Parameter	Typ.	Units
$R_{\theta JA}$	Junction-to-Ambient	50	℃/W

[a1]: Repetitive rating; pulse width limited by maximum junction temperature

[a3]: I_{SD} =10A,di/dt ≤100A/us,V_{DD}≤BV_{DS}, Start T_J=25℃

Typical Electrical and Thermal Characteristics

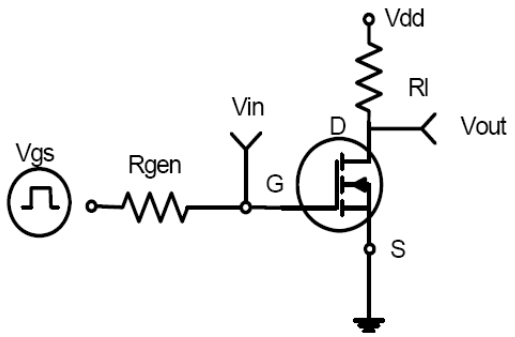

Figure 1:Switching Test Circuit

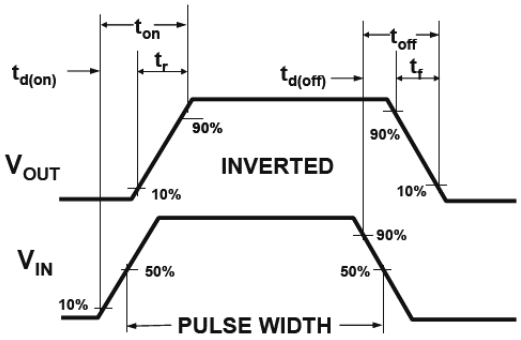

Figure 2:Switching Waveforms

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Typical Electrical and Thermal Characteristics (Curves)

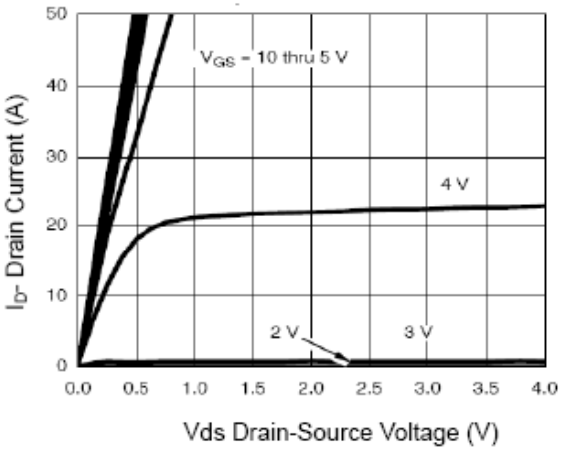

Figure 1 Output Characteristics

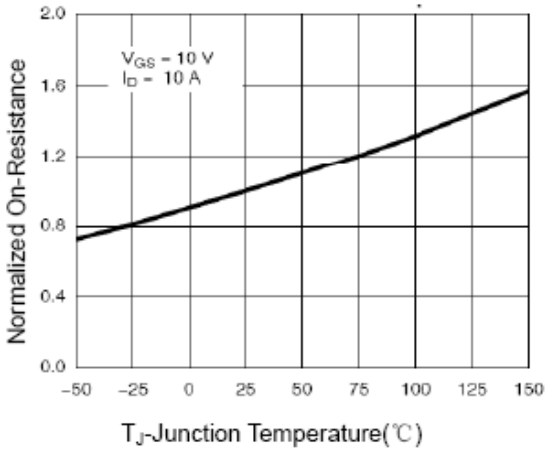

Figure 4 Rdson-JunctionTemperature

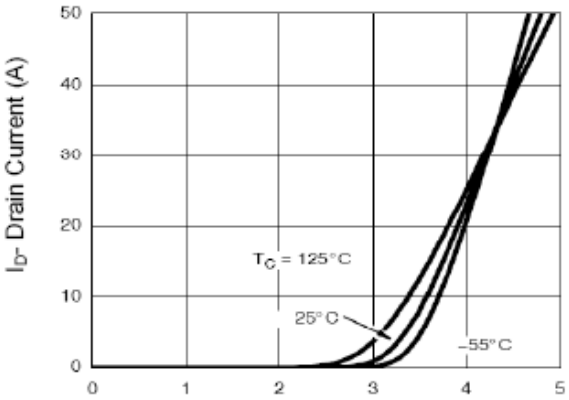

Figure 2 Transfer Characteristics

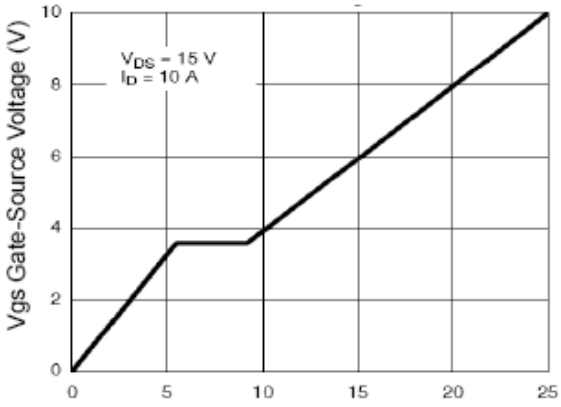

Figure 5 Gate Charge

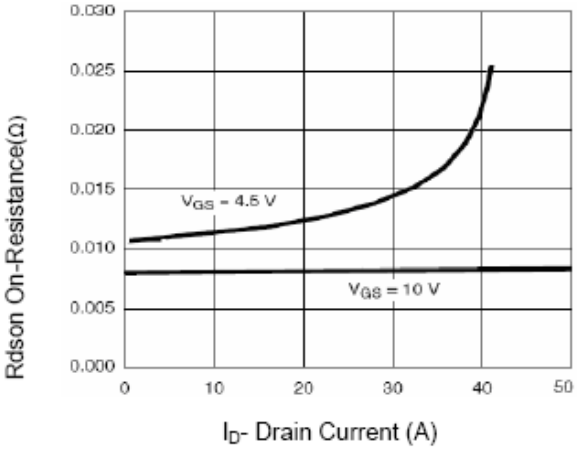

Figure 3 Rdson- Drain Current

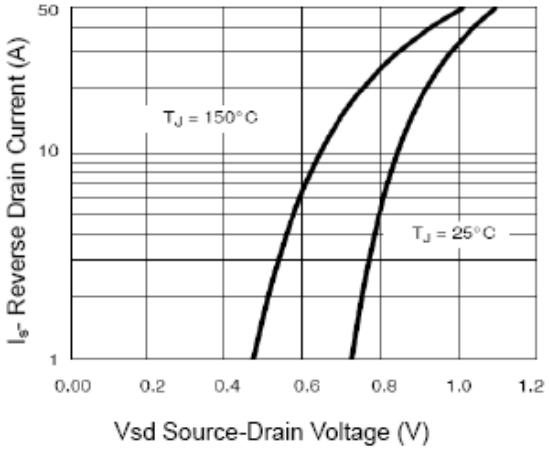

Figure 6 Source- Drain Diode Forward

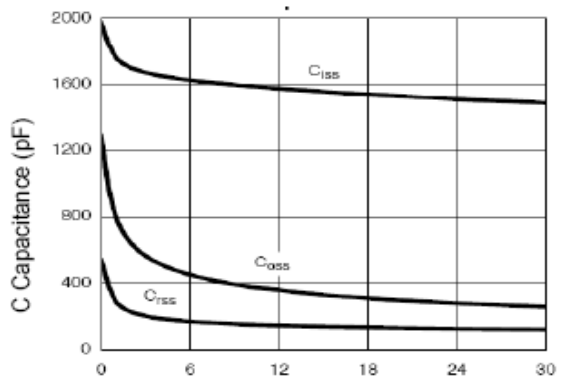

Figure 7 Capacitance vs Vds

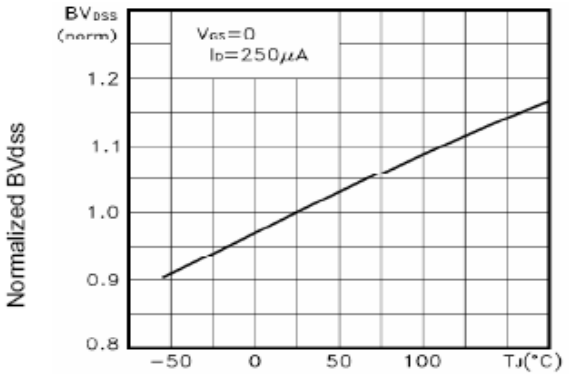

Figure 9 BV_{DSS} vs Junction Temperature

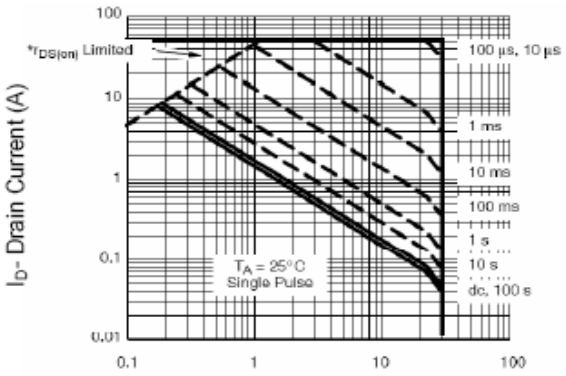

Figure 8 Safe Operation Area

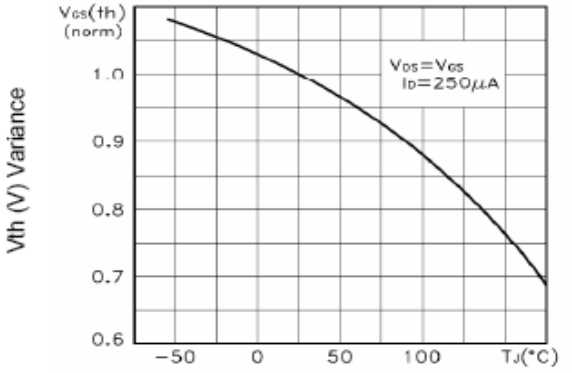

Figure 10 $V_{GS(th)}$ vs Junction Temperature

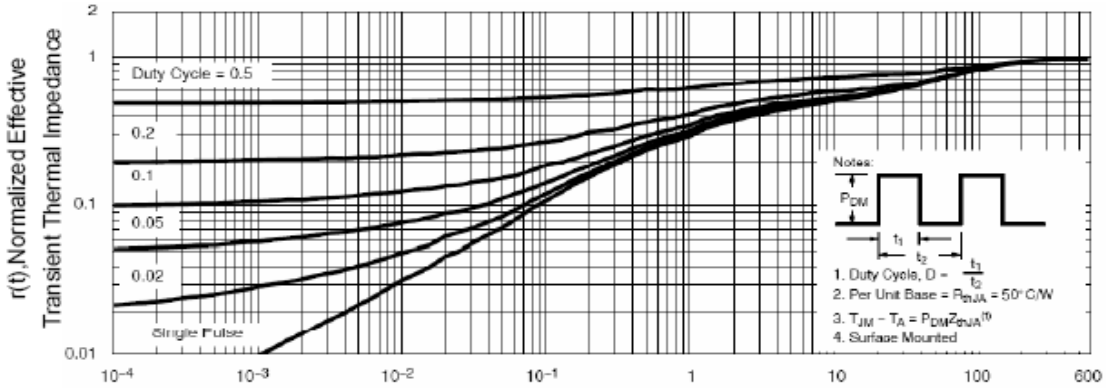

Figure 11 Normalized Maximum Transient Thermal Impedance